

**Search Notes**

Application/Control No.

10/806,139

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

CHIU, JANICE

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	140, first 400 patents	6/15/05	NKV
330	279, first 400 patents	08/06/05	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		11/04/05	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	11/04/05	NKV